



US00D408307S

**United States Patent** [19]  
**Blye**

[11] **Patent Number: Des. 408,307**  
[45] **Date of Patent: \*\*Apr. 20, 1999**

[54] **CIRCUIT TESTER**

D. 400,454 11/1998 Arnoux et al. .... D10/78

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[\*\*] **Term: 14 Years**

[57] **CLAIM**

The ornamental design for a circuit tester, as shown.

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[22] **Filed: May 29, 1998**

**DESCRIPTION**

[51] **LOC (6) CL ..... 10-04**

[52] **U.S. Cl. .... D10/78**

[58] **Field of Search ..... D10/78; D19/49,  
D19/56; 324/22.5, 133, 149, 158, 501,  
519, 527, 530, 555, 556**

FIG. 1 is an exploded perspective view showing the back, top and right side of the circuit tester showing my new design; and,

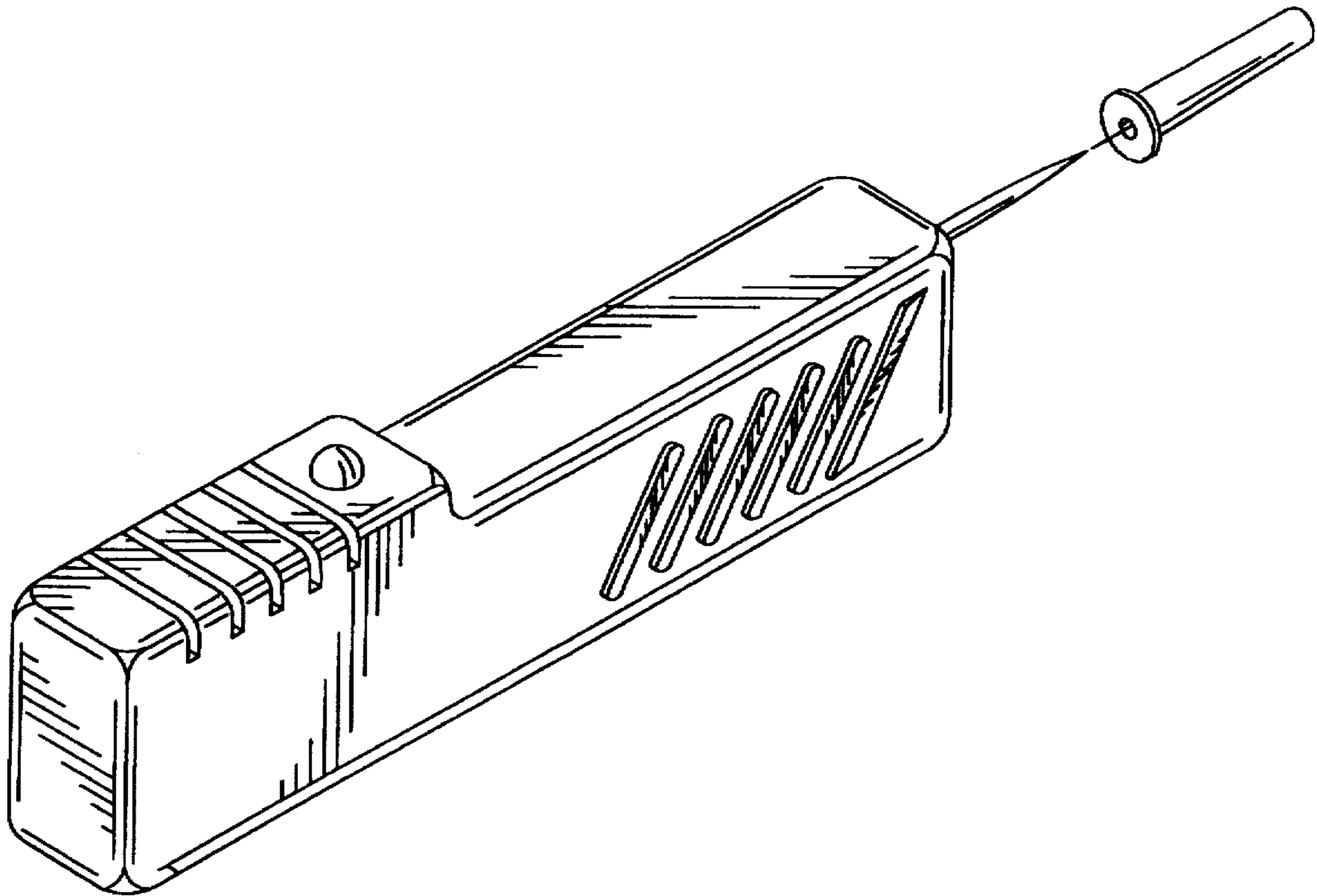
FIG. 2 is a perspective view showing the front, top and left side of the circuit tester of FIG. 1.

[56] **References Cited**

**U.S. PATENT DOCUMENTS**

D. 389,419 1/1998 Beha ..... D10/78

**1 Claim, 1 Drawing Sheet**



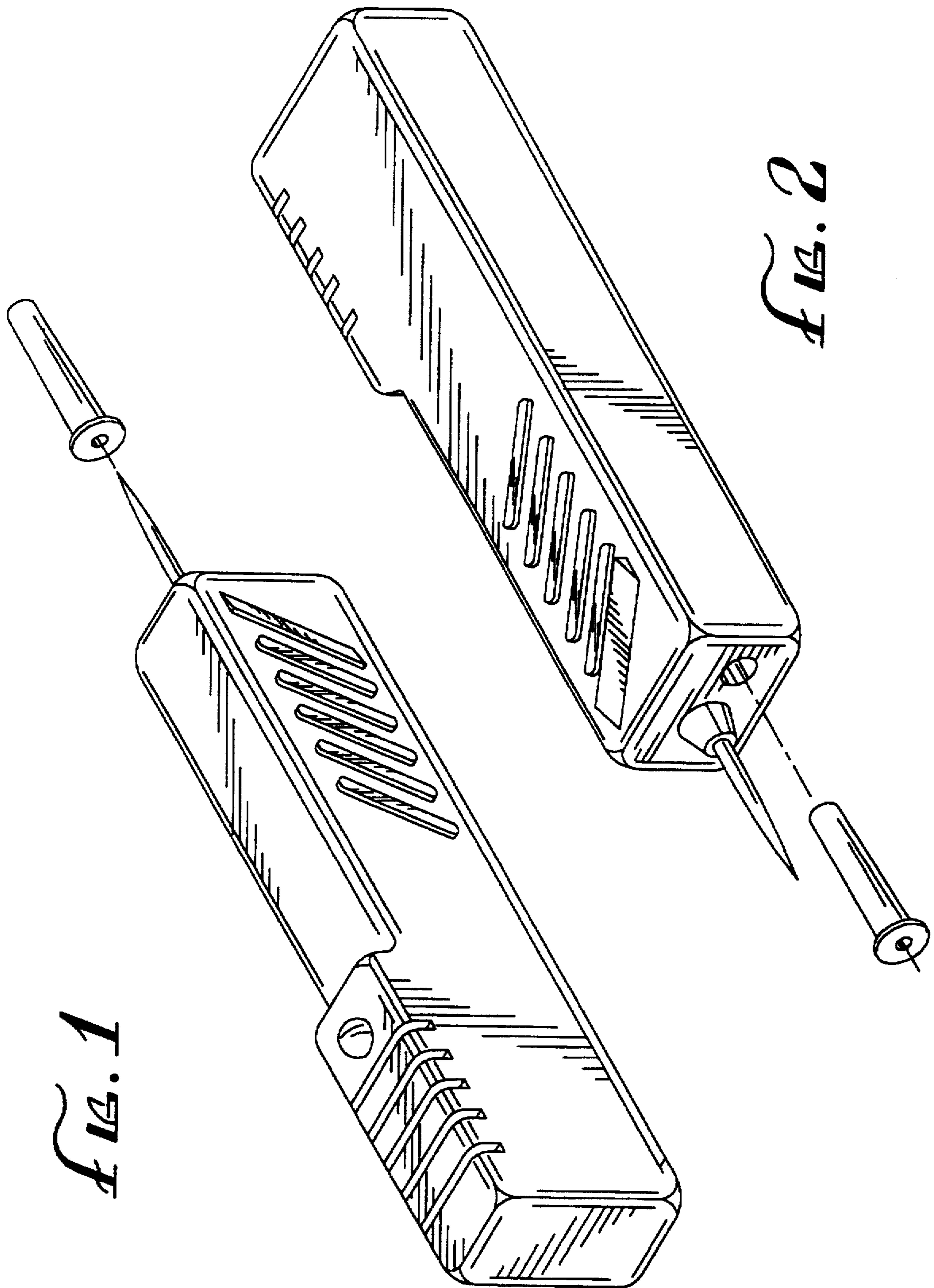


FIG. 1

FIG. 2